

Notice of References Cited	Application/Control No. 10/582,202		Applicant(s)/Patent Under Reexamination FUJITA ET AL.	
	Examiner KRISTY A. HAUPT		Art Unit 2876	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,039,250 A	03-2000	Ito et al.	235/380
*	B	US-6,032,857 A	03-2000	Kitagawa et al.	235/379
*	C	US-2001/0014869 A1	08-2001	Yoshizawa, Katsumi	705/14
*	D	US-7,360,091 B2	04-2008	Aikawa et al.	713/172
*	E	US-2003/0018577 A1	01-2003	Fukushima et al.	705/39
*	F	US-2003/0033203 A1	02-2003	Inoue et al.	705/14
*	G	US-2003/0163376 A1	08-2003	Inoue et al.	705/14
*	H	US-2004/0049421 A1	03-2004	Hagiwara, Kotaro	705/014
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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